Search Notes		
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/603,800	HAMURO ET AL.	ΓAL.
Examiner	Art Unit	
Ouang Nguyen Ph D	1633	

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Updated previous searches (see attached search notes)	10/3/2006	QN
Updated inventor's name search	10/3/2006	QN